

# Search Notes



Application No.

10/815,398

Examiner

Sin J. Lee

Applicant(s)

YUEH ET AL.

Art Unit

1752

## SEARCHED

Class	Subclass	Date	Examiner
430	270.1	1-9 -05	SJL
↓	905	↓	↓
	910		
	325		
	326		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR